AUTOMOTIVE GRADE



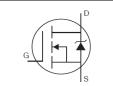
# AUIRFZ44Z AUIRFZ44ZS

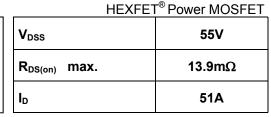
## Features

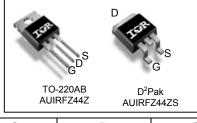
- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified \*

## Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.







G	D	S
Gate	Drain	Source

Deee next number	Deekene Ture	Standard Pack		Ordershie Bart Number	
Base part number	Package Type	Form	Quantity	Orderable Part Number	
AUIRFZ44Z	TO-220	Tube	50	AUIRFZ44Z	
	D <sup>2</sup> -Pak	Tube	50	AUIRFZ44ZS	
AUIRFZ44ZS	D -Pak	Tape and Reel Left	800	AUIRFZ44ZSTRL	

## Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	51	
$_{D}$ @ T <sub>C</sub> = 100°C Continuous Drain Current, V <sub>GS</sub> @ 10V (See Fig. 9)		36	А
I <sub>DM</sub>	Pulsed Drain Current ①	200	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Maximum Power Dissipation	80	W
	Linear Derating Factor	0.53	W/°C
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) 2	86	
E <sub>AS</sub> (tested)	Single Pulse Avalanche Energy Tested Value Ø	105	– mJ
I <sub>AR</sub>	Avalanche Current ① See Fig.15,16, 12a, 12b		Α
E <sub>AR</sub>	Repetitive Avalanche Energy 6		mJ
TJ	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	

## Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{ ext{ heta}JC}$	Junction-to-Case		1.87	
R <sub>0CS</sub>	Case-to-Sink, Flat, Greased Surface	0.50		°C/W
$R_{ heta JA}$	Junction-to-Ambient		62	C/W
$R_{ ext{ heta}JA}$	Junction-to-Ambient (PCB Mount, steady state) ®		40	

 $\mathsf{HEXFET}{}^{\textcircled{}}$  is a registered trademark of Infineon.

\*Qualification standards can be found at www.infineon.com



# AUIRFZ44Z/ZS

## Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	55			V	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250µA
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.054		V/°C	Reference to $25^{\circ}$ C, I <sub>D</sub> = 1mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		11.1	13.9	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 31A ④
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
gfs	Forward Trans conductance	22			S	V <sub>DS</sub> = 25V, I <sub>D</sub> = 31A
1	Drain-to-Source Leakage Current			20		V <sub>DS</sub> = 55V, V <sub>GS</sub> = 0V
IDSS	Drain-to-Source Leakage Current			250	μA	V <sub>DS</sub> = 55V,V <sub>GS</sub> = 0V,T <sub>J</sub> =125°C
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			200	<b>n</b> A	V <sub>GS</sub> = 20V
	Gate-to-Source Reverse Leakage			-200	nA	V <sub>GS</sub> = -20V

### Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

Q <sub>g</sub>	Total Gate Charge		29	43		I <sub>D</sub> = 31A
$Q_{gs}$	Gate-to-Source Charge		7.2	11	nC	$V_{DS} = 44V$
$Q_{gd}$	Gate-to-Drain Charge		12	18		V <sub>GS</sub> = 10V④
t <sub>d(on)</sub>	Turn-On Delay Time		14			$V_{DD} = 28V$
t <sub>r</sub>	Rise Time		68		-	I <sub>D</sub> = 31A
t <sub>d(off)</sub>	Turn-Off Delay Time		33		ns	R <sub>G</sub> = 15Ω,
t <sub>f</sub>	Fall Time		41			V <sub>GS</sub> = 10V ④
L <sub>D</sub>	Internal Drain Inductance		4.5		nH	Between lead, 6mm (0.25in.)
L <sub>S</sub>	Internal Source Inductance		7.5		111.1	from package
C <sub>iss</sub>	Input Capacitance		1420			V <sub>GS</sub> = 0V
C <sub>oss</sub>	Output Capacitance		240			V <sub>DS</sub> = 25V
C <sub>rss</sub>	Reverse Transfer Capacitance		130		~	f = 1.0MHz,See Fig.5
C <sub>oss</sub>	Output Capacitance		830		pF	$V_{GS} = 0V, V_{DS} = 1.0V f = 1.0MHz$
C <sub>oss</sub>	Output Capacitance		190			$V_{GS} = 0V, V_{DS} = 44V f = 1.0MHz$
C <sub>oss eff.</sub>	Effective Output Capacitance		300			$V_{GS}$ = 0V, $V_{DS}$ = 0V to 44V
Diode Char	acteristics					
	Parameter	Min.	Тур.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode)			51	•	MOSFET symbol showing the
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①			200	A	integral reverse
V <sub>SD</sub>	Diode Forward Voltage			1.2	V	$T_{J} = 25^{\circ}C, I_{S} = 31A, V_{GS} = 0V @$
		-				

#### Notes:

t<sub>rr</sub>

Qrr

t<sub>on</sub>

① Repetitive rating; pulse width limited by max. junction temperature. (See fig.11)

 $\odot$  Limited by T<sub>Jmax</sub> starting T<sub>J</sub> = 25°C, L = 0.18mH, R<sub>G</sub> = 25 $\Omega$ , I<sub>AS</sub> = 31A, V<sub>GS</sub> =10V. Part not recommended for use above this value.

23

17

35

26

ns

nC

Intrinsic turn-on time is negligible (turn-on is dominated by  $L_{s}+L_{D}$ )

Reverse Recovery Time

Forward Turn-On Time

Reverse Recovery Charge

- ④ Pulse width  $\leq$  1.0ms; duty cycle  $\leq$  2%.
- © C<sub>oss</sub> eff. is a fixed capacitance that gives the same charging time as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>.
   © Limited by T<sub>Jmax</sub>, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- ⑦ This value determined from sample failure population 100% tested to this value in production.
- This is applied to D2Pak, when mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and 8 soldering techniques refer to application note #AN-994.
- (9)  $R_{\theta}$  is rated at T<sub>J</sub> of approximately 90°C.

T<sub>J</sub> = 25°C ,I<sub>F</sub> = 31A , V<sub>DD</sub> = 28V

di/dt = 100A/µs ④



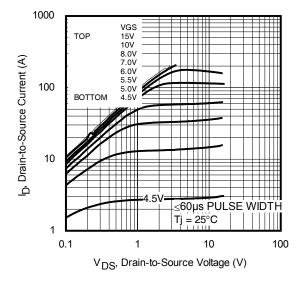


Fig. 1 Typical Output Characteristics

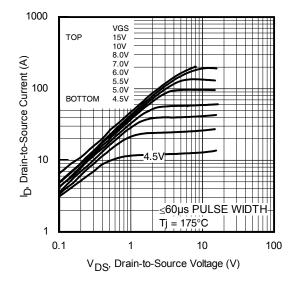


Fig. 2 Typical Output Characteristics

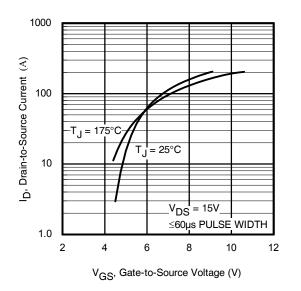


Fig. 3 Typical Transfer Characteristics

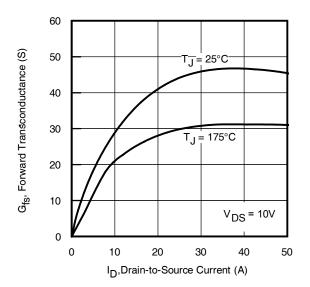


Fig. 4 Typical Forward Trans conductance vs. Drain Current



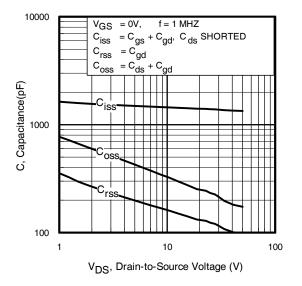


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

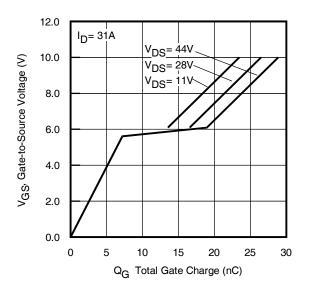


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

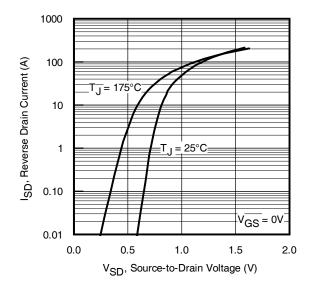


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

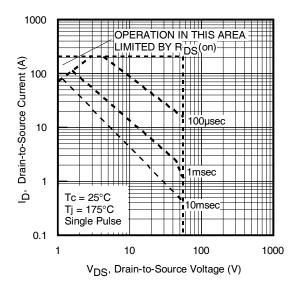
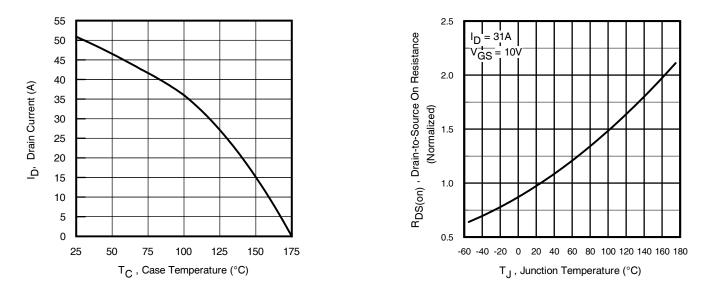
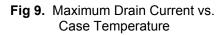
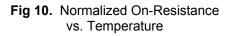


Fig 8. Maximum Safe Operating Area









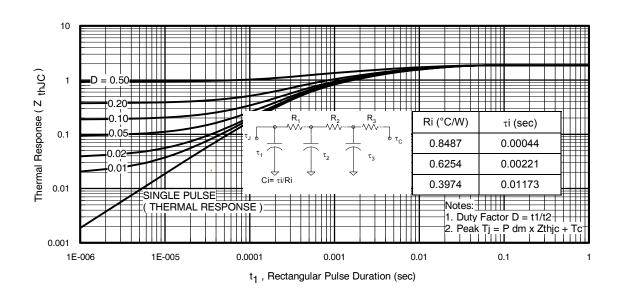


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



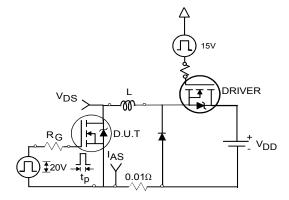


Fig 12a. Unclamped Inductive Test Circuit

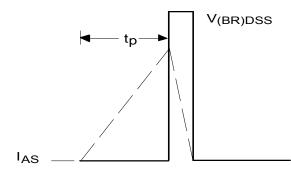


Fig 12b. Unclamped Inductive Waveforms

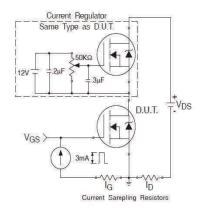


Fig 13a. Gate Charge Test Circuit

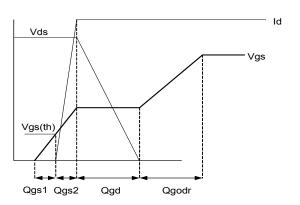


Fig 13b. Gate Charge Waveform

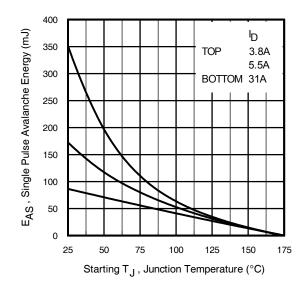


Fig 12c. Maximum Avalanche Energy vs. Drain Current

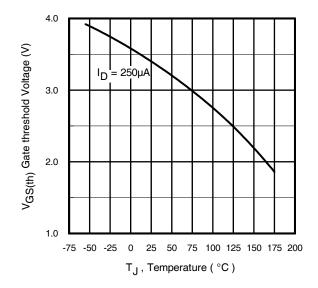


Fig 14. Threshold Voltage vs. Temperature



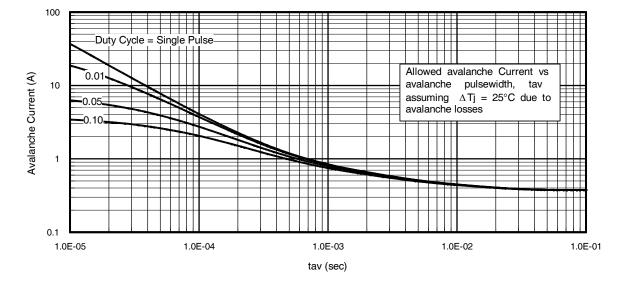


Fig 15. Avalanche Current vs. Pulse width

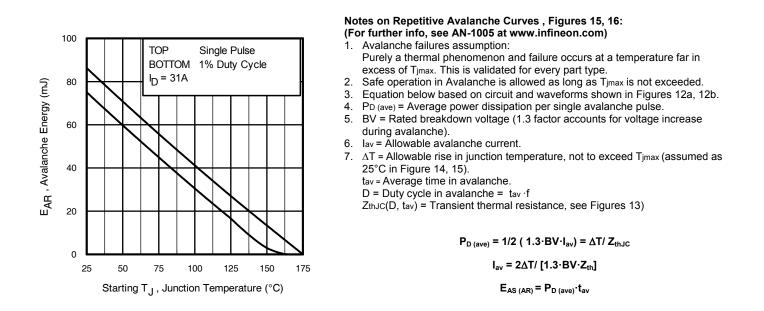


Fig 16. Maximum Avalanche Energy vs. Temperature

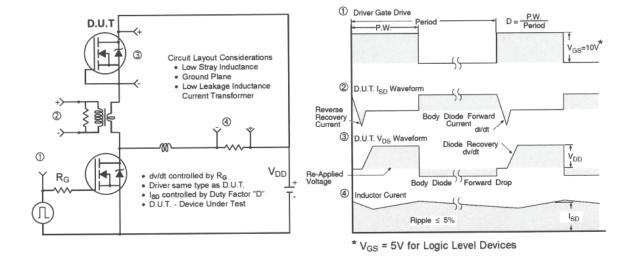


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

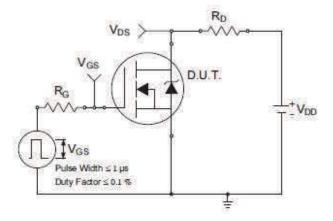


Fig 18a. Switching Time Test Circuit

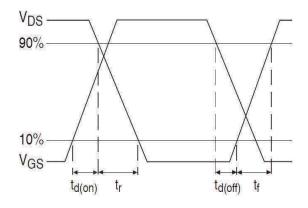
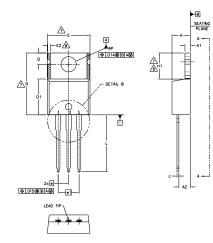


Fig 18b. Switching Time Waveforms



# AUIRFZ44Z/ZS

## TO-220AB Package Outline (Dimensions are shown in millimeters (inches))





- DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994. 1.-
- 2.-DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS].
- LEAD DIMENSION AND FINISH UNCONTROLLED IN L1 3.-
- DIMENSION D, D1 & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE 4.-MEASURED AT THE OUTERWOST EXTREMES OF THE PLASTIC BODY.
- DIMENSION 61, 63 & c1 APPLY TO BASE METAL ONLY. <u>/5.</u>\_ 6.-
- CONTROLLING DIMENSION : INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E, H1, D2 & E1 7.-
- DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING AND SINGULATION IRREGULARITIES ARE ALLOWED. 8.-
- 9.-
- AND SINGULATION IRREGULATION ARE ALLUNED. OUTLINE CONFORMS TO JEDEC TO-220, EXCEPT A2 (mox.) AND D2 (min.) WHERE DIMENSIONS ARE DERIVED FROM THE ACTUAL PACKAGE OUTLINE.

	DIMENSIONS				
SYMBOL	MILLIMETERS		INC	INCHES	
	Min.	MAX.	MIN.	MAX.	NOTES
A	3.56	4.83	.140	.190	
A1	1,14	1.40	.045	.055	
A2	2.03	2.92	.080	.115	
b	0.38	1.01	.015	.040	
ь1	0.38	0.97	.015	.038	5
b2	1.14	1.78	.045	.070	
b3	1.14	1.73	.045	.068	5
с	0.36	0.61	.014	.024	
c1	0.36	0.56	.014	.022	5
D	14.22	16.51	.560	.650	4
D1	8.38	9.02	.330	.355	
D2	11.68	12.88	.460	.507	7
E	9.65	10.67	.380	.420	4,7
E1	6.86	8.89	.270	.350	7
E2	-	0.76	-	.030	8
e	2.54	BSC	.100	BSC	
e1	5.08	BSC	.200	BSC	
H1	5.84	6.86	.230	.270	7,8
L	12.70	14.73	.500	.580	
L1	3.56	4.06	.140	.160	3
øР	3.54	4.08	.139	.161	
Q	2.54	3.42	.100	.135	

#### LEAD ASSIGNMENTS

<u>HEXFET</u> 1.- GATE 2.- DRAIN 3.- SOURCE

IGBTs, CoPACK

1.- GATE 2.- COLLECTOR 3.- EMITTER

DIODES

1.- ANODE 2.- CATHODE 3.- ANODE

### **TO-220AB Part Marking Information**

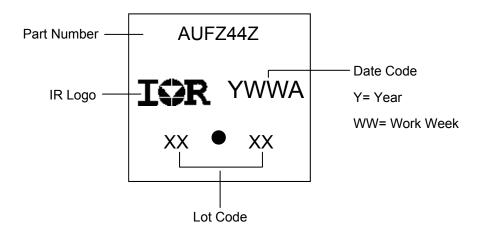
e1 A

VIEW A-A

DETAIL B

-b1,b3-1/5

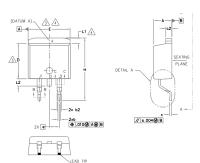
SECTION C-C & D-D





# AUIRFZ44Z/ZS

## D<sup>2</sup>Pak (TO-263AB) Package Outline (Dimensions are shown in millimeters (inches))



NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5 DIMENSION 61, 63 AND c1 APPLY TO BASE METAL ONLY.

6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.

7. CONTROLLING DIMENSION: INCH.

8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

	PLATING 
VEW A-A	POTATED 90° CW SCALE 8:1 B SEATING PLANE

S Y M	DIMENSIONS				
В	MILLIM	ETERS	INC	HES	O T E S
0 L	MIN.	MAX.	MIN.	MAX.	L S
А	4.06	4.83	.160	.190	
A1	0.00	0.254	.000	.010	
Ь	0.51	0.99	.020	.039	
Ь1	0.51	0.89	.020	.035	5
b2	1.14	1.78	.045	.070	
b3	1.14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
с1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	_	.270	—	4
E	9.65	10.67	.380	.420	3,4
E1	6.22	_	.245	_	4
е	2.54	BSC	.100	BSC	
Н	14.61	15.88	.575	.625	
L	1.78	2.79	.070	.110	
L1	_	1.68	-	.066	4
L2	_	1.78	-	.070	
L3	0.25	BSC	.010	BSC	

LEAD ASSIGNMENTS

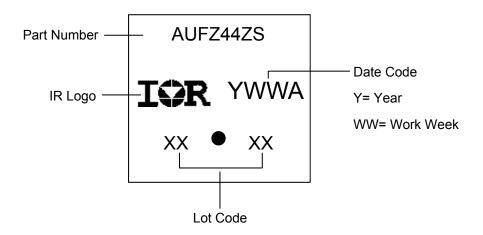
HEXFET

1.- GATE 2, 4.- DRAIN 3.- SOURCE

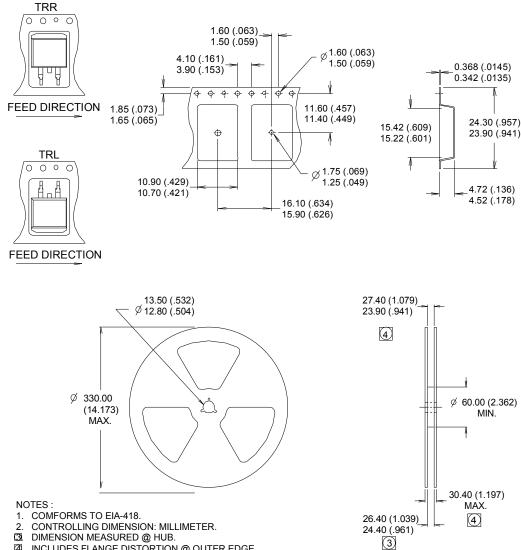
DIODES 1.- ANODE (TWO DIE) / OPEN (ONE DIE) 2. 4.- CATHODE 3.- ANODE

> I<u>GBTs, CoPACK</u> 1.- GATE 2, 4.- COLLECTOR 3.- EMITTER

## D<sup>2</sup>Pak (TO-263AB) Part Marking Information



## D<sup>2</sup>Pak (TO-263AB) Tape & Reel Information (Dimensions are shown in millimeters (inches))



INCLUDES FLANGE DISTORTION @ OUTER EDGE.



## **Qualification Information**

Industrial and		Automotive (per AEC-Q101)				
			is part number(s) passed Automotive qualification. Infineon's consumer qualification level is granted by extension of the higher el.			
		TO-220 Pak	N/A			
Moisture	Moisture Sensitivity Level		MSL1			
	Machine Model		Class M2 (+/- 200V) <sup>†</sup> AEC-Q101-002			
ESD	Human Body Model	Class H1A (+/- 500V) <sup>†</sup> AEC-Q101-001				
Charged Device Model		Class C5 (+/- 1125V) <sup>†</sup> AEC-Q101-005				
RoHS Co	HS Compliant Yes		Yes			

† Highest passing voltage.

### **Revision History**

Date	Comments			
12/4/2015	<ul><li>Updated datasheet with corporate template</li><li>Corrected ordering table on page 1.</li></ul>			
09/25/17	<ul> <li>Corrected typo error on part marking on pages 9,10.</li> </ul>			

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